# 1750 LCR Digibridge Instruction Manual 

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The material in this manual is for informational purposes only and is subject to change，without notice．QuadTech assumes no responsibility for any error or for consequential damages that may result from the misinterpretation of any procedures in this publication．

## WARNING

Potentially dangerous voltages may be present on front and rear panel terminals．Follow all warnings in this manual when operating or servicing this instrument．Dangerous levels of energy may be stored in capacitive devices tested by this unit．
Always make sure the high voltage indicator is not on when connecting or disconnecting the device under test．

$\triangle$
Product will be marked with this symbol（ISO\＃3684）when it is necessary for the user to refer to the instruction manual in order to prevent injury or equipment damage．

ニーー Product marked with this symbol（IEC417）indicates presence of direct current．

$\triangle$Product will be marked with this symbol（ISO\＃3684）when voltages in excess of 1000 V are present．

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## Warranty

QuadTech warrants that Products are free from defects in material and workmanship and, when properly used, will perform in accordance with QuadTech's applicable published specifications. If within one (1) year after original shipment it is found not to meet this standard, it will be repaired, or at the option of QuadTech, replaced at no charge when returned to a QuadTech service facility.

Changes in the Product not approved by QuadTech shall void this warranty.
QuadTech shall not be liable for any indirect, special or consequential damages, even if notice has been given of the possibility of such damages.

This warranty is in lieu of all other warranties, expressed or implied, including, but not limited to any implied warranty or merchantability or fitness for a particular purpose.

## SERVICE POLICY

QuadTech's service policy is to maintain product repair capability for a period of at least five (5) years after original shipment and to make this capability available at the then prevailing schedule of charges.

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## Specifications

## LCR Features

| Primary Display: | L, $\mathrm{C}, \mathrm{R}$ and $\|\mathrm{Z}\|$ |
| :--- | :--- |
|  | L: $0.0001 \mu \mathrm{H}-9999.9 \mathrm{H}$ |
|  | C: $0.0001 \mathrm{pF}-9999.9 \mathrm{mF}$ |
|  | R: $0.0001 \Omega-9999.9 \mathrm{M} \Omega$ |
|  | Z: $0.0001 \Omega-9999.9 \mathrm{M} \Omega$ |

Secondary Display:
$\mathrm{D}, \mathrm{Q}, \mathrm{R}$ and $\theta$
D: 0.0001 - 99999
Q: $0.0001-99999$
R: $0.0001 \Omega-9999.9 \mathrm{M} \Omega$
$\theta:-90.00^{\circ}-+90.00^{\circ}$

5 Digit Display \& LED Indicators

5 Digit Display \& LED Indicators (D with C)
(Q with R or L)
(R with C)

Test Voltage: $\quad 10 \mathrm{mV}-2.5 \mathrm{~V}$ (programmable in 10 mV steps)
Test Frequency: $\quad 43$ preset test frequencies from 20 Hz to 200 kHz
Over 500 programmable test frequencies from 20 Hz to 200 kHz
Test Setups: $\quad 10$ Memory Locations with Store/Recall
Measurement Rate: Slow, Medium or Fast
Up to 20 measurements/second in Fast Mode
Measurement Mode: Continuous Mode or Triggering Mode
Averaging: $\quad 0-10$ measurements
Accuracy: Primary Parameter (LCR\&Z) Basic Accuracy: $\pm 0.1 \%$
Secondary Parameter (D\&Q) Basic Accuracy: $\pm 0.001$
Secondary Parameter (R) Basic Accuracy: $\pm 0.1 \%$
Secondary Parameter ( $\theta$ ) Basic Accuracy: $\pm 0.1^{\circ}$

## General Features

Bias Voltage: External: 0-35VDC

Constant Source: Output Source Impedance: OFF or ON ( $25 \Omega$ or $100 \Omega$ )
Circuit: $\quad$ Equivalent Series or Parallel

Interfaces: IEEE-488, Handler

| Ranging: | Auto Ranging with Manual Hold (7 ranges) |
| :--- | :--- |
| Binning: | 9 PASS Bins for Primary Parameters (L, C, R \& Z) |
|  | 1 FAIL Bin for Primary \& Secondary Parameters (LCR\&Z and DQR\& $\theta$ ) |


| Mechanical: | Bench Mount |
| :--- | :--- |
|  | Dimensions: $(\mathrm{w} \times \mathrm{h} \times \mathrm{d}): 16.0 \times 5.0 \times 13.75$ inches $(400 \times 125 \times 344 \mathrm{~mm})$ |

Weight: $\quad 14.2 \mathrm{lbs}(6.5 \mathrm{~kg})$ net, $21 \mathrm{lbs}(9.6 \mathrm{~kg})$ shipping
Environmental: Operating: $10^{\circ} \mathrm{C}$ to +40 oC
Storage: $0^{\circ} \mathrm{C}$ to +50 oC
Humidity: <85\%
Warm-up Time: 30 minutes
Power:

- 90-125V AC
- 50 or 60 Hz
- 180-250V AC
- 40W max, 40W typical

Supplied:

- Instruction Manual
- AC Power Cable
- Calibration Certificate
- 4 BNC to 2 Kelvin Clip Lead Set
$\begin{array}{lll}\text { Ordering } & \text { Description } & \text { Catalog No. } \\ \text { Information: } & \text { 1750 LCR Digibridge } & 1750\end{array}$


## Accessories

## Accessories Included

| Item | Quantity | QuadTech P/N |
| :--- | :--- | :--- |
| AC Power Cord | 1 | $4200-0300$ |
| $0.6 A$ Slow Blow Screw Cap Fuse 115V Operation | 1 | 520023 |
| 0.3A Slow Blow Screw Cap Fuse 230V Operation | 1 | 520025 |
| 4-BNC to 2-Kelvin Clips Lead Set | 1 | $1700-03$ |
| Instruction Manual | 1 | 150458 |
| Calibration Certificate | 1 | N/A |

## Accessories/Options Available

| Item | Quantity | QuadTech P/N |
| :--- | :--- | :--- |
| Axial/Radial Component Test Fixture | 1 | $1700-01$ |
| Axial/Radial Remote Component Test Fixture | 1 | $1700-02$ |
| 4-BNC to 2-Kelvin Clips Lead Set | 1 | $1700-03$ |
| 4-BNC to 4-Banana Plugs Lead Set | 1 | $1700-04$ |
| 4-BNC to Chip Component Tweezers | 1 | $1700-05$ |
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## Safety Precautions

The 1750 LCR Digibridge instrument can provide an output voltage as high as 2.5 VDC (35VDC external Bias Voltage) to the device under test (DUT). Although the Digibridge unit is designed with full attention to operator safety, serious hazards could occur if the instrument is used improperly and these safety instructions are not followed.

1. The 1750 Digibridge instrument is designed to be operated with its chassis connected to earth ground. The instrument is shipped with a three-prong power cord to provide this connection to ground. This power cord should only be plugged in to a receptacle that provides earth ground. Serious injury can result if the 1750 Digibridge is not connected to earth ground.
2. Tightly connect BNC cable(s) to the (silver) HIGH (+) terminal. If this is not done, the DUT's casing can be charged to the high voltage test level and serious injury or electrical shock hazards could result if the DUT is touched.
3. Never touch the metal of the High Voltage probe directly. Touch only the insulated parts of the lead(s).
4. Never touch the test leads, test fixture or DUT in any manner (this includes insulation on all wires and clips) when the bias voltage is applied and the red BIAS ON light is ON.
5. Before turning on the 1750 Digibridge unit, make sure there is no device (DUT) or fixture connected to the test leads.
6. When the red BIAS ON LED is ON or flashing, NEVER touch the device under test, the lead wires or the output terminals.
7. Before touching the test lead wires or output terminals make sure:
a) Any capacitive device has had enough discharge time.
b) The red BIAS ON LED is OFF.
8. In the case of an emergency, turn OFF the POWER switch using a "hot stick" and disconnect the AC power cord from the wall. DO NOT TOUCH THE 1750 Digibridge INSTRUMENT.
9. When the 1750 Digibridge instrument is used in remote control mode, be extremely careful. The High Voltage Output is being turned on and off with an external signal.

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## Condensed Operating Instructions

## General Information

The 1750 LCR Digibridge is an instrument for measuring primary parameters of inductance (L), capacitance (C), resistance (R) and impedance ( $|Z|$ ). The Secondary parameters measured are dissipation factor $(D)$, quality factor (Q), resistance (R) and phase angle ( $\theta$ ). Bin Number can be displayed with GO/NG indication on the front panel. Instrument preset test voltage, frequency or amperage may be selected on the front panel and shown on the fourth display. Connection to the device under test is through 4 BNC terminals on the front panel.

## Start-Up

The 1750 Digibridge unit can be operated from a power source between $90-125 \mathrm{VAC}$ or $180-250 \mathrm{VAC}$ at a power line frequency of 50 or 60 Hz . The standard 1750 unit is shipped from QuadTech with a 0.6 A fuse in place for AC 115 Voperation. A 0.3 A fuse is included in the accessories package for 230 V operation. The 1750 unit is shipped with the line voltage selector set for 115 V . Refer to paragraph 1.4.3 to change a fuse and to change the line voltage selector.

Connect the 1750 instrument's AC power cord to the source of proper voltage. The instrument is to be used only with 3-wire grounded outlets.

Press the [POWER] button on the front panel to apply power. To switch the power off press the [POWER] button again or if measurements are to be made proceed with Test Parameter Set-Up below. Note: the 1750 unit should warm-up for a minimum of 30 minutes prior to use.

## Test Parameter Set-up

The Test Parameter Table illustrates the parameters that can be set prior to test. Refer to II 2.5 for the correct connection to device under test. Refer to II 2.3.7 for the correct zeroing function. Read this instruction manual in full prior to using the 1750 LCR Digibridge.

## Test Parameter Table

| $\begin{aligned} & \text { A } \\ & \text { DISP } \end{aligned}$ | RANGE | $\begin{aligned} & \text { B } \\ & \text { DISP } \end{aligned}$ | CIRCUIT | ZERO | Test Volt | Test Freq | BIAS | TRIGGER | Operation |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| L | Auto | Q | Series | Open | $\begin{aligned} & \hline 0.01 \mathrm{~V} \\ & \text { To } \\ & 2.50 \mathrm{~V} \end{aligned}$ | $\begin{aligned} & 20 \mathrm{~Hz} \\ & \text { To } \\ & 200 \mathrm{kHz} \end{aligned}$ | ON | EXT | Local |
| C | Manual | D | Parallel | Short |  |  | OFF | INT | Remote |
| R |  | R |  |  |  |  |  |  |  |
| Z |  | $\theta$ |  |  |  |  |  |  |  |

## Measurement Mode

1. Turn POWER ON.
2. Allow the 1750 instrument to warm-up for 30 minutes.
3. Select Primary Parameter.
4. Select Frequency.
5. Select Test Voltage.
6. Select Measurement Range.
7. Select Measurement Rate
8. Select Secondary Measurement.
9. Select Equivalent Circuit (Series or Parallel).
10. Connect Test Cables or Test Fixture.
11. Enable Zero Function.
12. Connect Device Under Test (DUT).

Figure COI-1 illustrates the connection of a device under test (DUT) to the 1750 instrument using the BNC to Kelvin Clip Lead Set provided with the unit.


Figure COI-1: Connection to DUT using Kelvin Clip Lead Set

## Section 1: Introduction

### 1.1 Unpacking and Inspection

Inspect the shipping container before opening. If damaged contact the carriers agent immediately. Inspect the 1750 Digibridge unit for any damage. If the instrument appears damaged or fails to meet specifications, notify QuadTech (refer to instruction manual front cover) or its local representative. Retain the shipping carton and packing material for future use such as returning for recalibration or service.

### 1.2 Product Overview

The 1750 LCR Digibridge is an economical, user friendly meter for production or laboratory testing of inductors, capacitors and other LCR components. The 1750 Digibridge makes primary measurements of L, C, R and Z and secondary measurements of $\mathrm{D}, \mathrm{Q}, \mathrm{R}$ and $\theta$. $\mathrm{L}, \mathrm{C}, \mathrm{R}$ and Z measurements are made at frequencies ranging from 20 Hz to 200 kHz with a basic accuracy of $\pm 0.1 \%(1 \mathrm{kHz})$. The basic accuracy of the secondary parameters D and Q is $\pm 0.0$ and for $\theta$ the basic accuracy is $\pm 0.01^{\circ}$. Auto/Manual Ranging is selectable for the five measurement ranges. A Fast/Medium/Slow Measurement Rate provides speed versus accuracy capability. Bias Voltage can be applied to capacitors by connection of an external voltage source to the rear panel. Bias levels from 0V to 35VDC (External) are attainable. The test voltage level is programmable at 0.01 V to 2.50 V RMS. An internal zeroing function (Open/Short) is provided and selectable from the front panel. Displayed on the front panel are Bin Number with Go/NG indication and Preset Test voltage, frequency or amperage. Connection to the device under test (DUT) is through 4 BNC terminals on the front panel of the 1750 Digibridge unit.

### 1.3 Controls and Indicators

### 1.3.1 Front Panel Controls and Indicators

Figures 1-1 and 1-2 illustrate the controls and indicators on the front panel of the 1750 Digibridge unit. Table 1-1 identifies them with description and function.


Figure 1-1: 1750 Front Panel Controls and Indicators


NOTE:
The lower case letters inside the white buttons are for identification purposes only.

They are not on the actual keypad of the 1750 instrumen

Figure 1-2: Close Up 1750 Front Panel Keypad (4a-t)

Table 1-1: 1750 Front Panel Controls and Indicators

| Reference <br> Number <br> Fig: $\mathbf{1 - 1 \&} \mathbf{1 - 2}$ | Name | Type | Function |
| :--- | :--- | :--- | :--- |
| $\mathbf{1}$ | POWER | Beige Push Button Switch | Apply power: 1 (ON) 0 (OFF) |
| $\mathbf{2}$ | UNKNOWN |  |  |
| 2 a | GUARD | Silver Screw/Banana plug | Instrument Chassis Ground |
| 2 b | LCUR | Silver BNC Connector | Low Current Connection |$|$| 2 c | LPOT | Silver BNC Connector | Low Potential Connection |  |
| :--- | :--- | :--- | :--- | :---: |
| 2 d | HPOT | Silver BNC Connector | High Potential Connection |  |
| 2 e | HCUR | Silver BNC Connector | High Current Connection |  |
| $\mathbf{3}$ | TRIGGER |  |  |  |
| 3 a | EXT. | Red LED | When lit, External Trigger is enabled |  |
| 3 b | EXT./INT | Beige Push Button Switch | Select External or Internal Trigger |  |

Table 1-1: 1750 Front Panel Controls and Indicators (Continued)

| Reference Number Fig: 1-1\& 1-2 | Name | Type | Function |
| :---: | :---: | :---: | :---: |
| 4s | $\begin{aligned} & \hline 9 \\ & \text { FREQ } \\ & \hline \end{aligned}$ | Beige Push Button Switch | Numerical Key <br> Select Test Frequency $(1 \mathrm{kHz}-200 \mathrm{kHz})$ |
| 4t | $\begin{aligned} & \hline 0 \\ & \theta \text { NOM } \end{aligned}$ | Beige Push Button Switch | Numerical Key Specify a nominal value for $\theta$ (the phase angle) |
| 5 | PRESET |  |  |
| 5a | Display | 3 digit | Display test voltage, frequency or current |
| 5b | VOLT | Green LED | When lit, test voltage is shown in Preset display |
| 5c | FREQ | Green LED | When lit, test frequency is shown in Preset display |
| 5d | AMP | Green LED | When lit, test current is shown in Preset display |
| 6 | BIN NO. |  |  |
| 6a | Display | 1 digit | Display Bin \# or measurement range |
| 6b | GO | Green LED | When lit, DUT measurement is a PASS per set limit |
| 6c | NG | Red LED | When lit, DUT measurement is a FAIL per set limit |
| 6d | LOAD | Green LED | When lit, Load correction value added to DUT msmt |
| 7 | B DISPLAY |  |  |
| 7a | Display | 5 digit | Display Secondary Parameter (D, Q, R \& $\theta$ ) |
| 7b | Q | Green LED | When lit, Quality Factor is shown on B display |
| 7c | D | Green LED | When lit, Dissipation Factor is shown on B display |
| 7d | R | Green LED | When lit, Resistance is shown on B display |
| 7 e | $\theta$ | Green LED | When lit, Phase Angle is shown on B display |
| 7f | PAR | Green LED | When lit, Parallel equivalent circuit employed |
| 7 g | SER | Green LED | When lit, Series equivalent circuit employed |
| 7h | KEY LOCK | Green LED | When lit, front panel is locked out |
| 8 | A DISPLAY |  |  |
| 8a | Display | 5 digit | Display Primary Parameter (L, C, R \& $\|\mathrm{Z}\|$ ) |
| 8b | L | Green LED | When lit, Inductance is shown on A display |
| 8c | C | Green LED | When lit, Capacitance is shown on A display |
| 8d | R | Green LED | When lit, Resistance is shown on A display |
| 8 e | \| Z | | Green LED | When lit, Impedance is shown on A display |
| 8f | REM | Green LED | When lit, unit is used in Remote control |
| 8 g | AUTO | Green LED | When lit, Auto Ranging is employed |
| 8h | $\Delta$ | Green LED | When lit, Deviation from Nominal is displayed |
| 8I | $\Delta \%$ | Green LED | When lit, \% Deviation from Nominal is displayed |
| 9 | SELECT BUTTONS |  |  |
| 9a | A DISPLAY | Beige Push Button Switch | Select Primary parameter to be displayed (LCR\&Z) |
| 9b | RATE | Beige Push Button Switch | Select Measurement Rate (Fast, Slow or Medium) |
| 9c | AUTO | Beige Push Button Switch | Select Auto or Manual Ranging |
| 9d | $\leftarrow$ RANGE | Beige Push Button Switch | Descend through measurement ranges |
| 9 e | RANGE $\rightarrow$ | Beige Push Button Switch | Ascend through measurement ranges |
| 9f | B DISPLAY | Beige Push Button Switch | Select Secondary Parameter (QDR\&日) |
| 9 g | (CKT.) PAR | Beige Push Button Switch | Select Parallel equivalent circuit representation |
| 9h | (CKT.) SER | Beige Push Button Switch | Select Series equivalent circuit representation |
| 9I | ZERO OPEN | Beige Push Button Switch | Select Open Circuit compensation |
| 9 j | ZERO SHORT | Beige Push Button Switch | Select Short Circuit compensation |
| 9k | BIAS ON | Red LED | Bias Voltage is present at output terminals |
| 91 | BIAS | Beige Push Button Switch | Select Bias Voltage ON or OFF |

Table 1-1: 1750 Front Panel Controls and Indicators (Continued)

| Reference <br> Number <br> Fig: $\mathbf{1 - 1 \&} \mathbf{1 - 2}$ | Name | Type | Function |
| :--- | :--- | :--- | :--- |
| 9 m | LOCAL | Beige Push Button Switch | Select Local Operation ON or OFF |
| 9 n | V I / F | Beige Push Button Switch | Select Preset Voltage, Frequency or Current |
| 9 o | VTEP | Beige Push Button Switch | Step down through Preset values |
| 9 p | STEP $\boldsymbol{B}$ | Beige Push Button Switch | Step up through Preset values |

### 1.3.2 Rear Panel Controls and Connectors

Figure 1-3 illustrates the controls and connectors on the rear panel of the 1750 Digibridge instrument. Table 1-2 identifies them with description and function.


Figure 1-3: 1750 Rear Panel Controls and Connectors
Table 1-2: 1750 Rear Panel Controls and Connectors

| Reference <br> Number <br> Figure 1-3 | Name | Type | Function |
| :--- | :--- | :--- | :--- |
| 1 | FAN | DC 24V 0.17A Fan | Cool unit |
| 2 | BUZZER | Hole | Channel to emit buzzer signal |
| 3 | BUZZER LEVEL | Silver Rotating Knob | Turn Buzzer ON/OFF or increase/decrease level |
| 4 | EXT. BIAS | Silver BNC connector | Connection for external bias source |
| 5 | LINE VOLTAGE | Red 2-position slide switch | Select 115V or 230V operation |
| 6 | LINE FUSE | Black screw cap fuse | Short Circuit protection <br> $0.6 A$ fuse: 95-125V, 0.3A fuse: 190-250V |
| 7 | AC LINE INPUT | Black 3-wire AC receptacle | Input for AC power |
| 8 | HANDLER INTERFACE | Blue 24-PIN connector | Connect Handler to 1750 unit |
| 9 | TALK/LISTEN | Red 4-position DIP switch | Select Talk Listen function of 1750 unit |
| 10 | IEEE-488 INTERFACE | Blue 24-PIN connector | Connect IEEE-488 Interface to 1750 unit |

### 1.4 Installation

### 1.4.1 Dimensions

The 1750 Digibridge instrument is supplied in bench configuration (a cabinet with resilient feet for placement on a table). A front bail is provided so that the unit can be tilted back for convenient operator viewing. Figure 1-4 illustrates the 1750 instrument dimensions.


Figure 1-4: 1750 Instrument Dimensions

### 1.4.2 Instrument Positioning

The 1750 Digibridge instrument contains four LCD displays, a primary parameter and a secondary parameter display both with 5 -digit resolution for convenient viewing. The unit also contains a 1-digit Bin No display and a 3-digit Preset display. The optimum angle for viewing is slightly down and about $10^{\circ}$ either side of center. For bench operation the front bail should be used to angle the instrument up. In bench or rack mount applications the instrument should be positioned with consideration for ample air flow around the rear panel. An open space of at least 3 inches ( 75 mm ) is recommended behind the rear panel.

### 1.4.3 Power Requirements

The 1750 Digibridge can be operated from a power source of 90 to 125 VAC or 180 to 250 VAC. Power connection is via the rear panel through a standard receptacle. Before connecting the 3 -wire power cord between the unit and AC power source make sure the voltage selection switch and fuse on the rear panel (Figure 1-5) are in accordance with the power source being used. Use a $0.6 \mathrm{~A}, 250 \mathrm{~V}$ SB fuse for 115 V operation and a $0.3 \mathrm{~A}, 250 \mathrm{~V} \mathrm{SB}$ fuse for 230 V operation. Always use an outlet that has a properly connected protection ground.

## Procedure for Changing A 1750 Digibridge Fuse

## WARNING <br> MAKE SURE THE UNIT HAS BEEN DISCONNECTED FROM ITS AC POWER SOURCE FOR AT LEAST 5 MINUTES BEFORE PROCEEDING.

Figure 1-5 illustrates the voltage selector, fuse holder and inlet module on the bottom right of the rear panel. Review these instructions before removing the black screw cap fuse on the rear panel of the 1750 instrument.

- Make sure the power switch is OFF and the power cord is disconnected from the unit and the AC power source.
- Inspect if the fuse is functional by measuring resistance ( $<15 \Omega$ ) with an ohmmeter.
- Using a flat head screwdriver, turn the screwcap about $60^{\circ}$ counterclockwise. The screwcap should protrude about 3.0 cm from the socket.
- Remove screwcap. Replace with new, same rated 0.6A, 250V SB or 0.3A 250V SB fuse.
- Using a flat head screwdriver, turn the screwcap about $60^{\circ}$ clockwise.
- Make sure the voltage selector switch is in accordance with the power source being used.


Figure 1-5: Fuse \& Voltage Selector (1750 Digibridge Rear Panel)

### 1.4.4 Safety Inspection

$\triangle$
Before operating the instrument inspect the screw cap fuse receptacle on the rear panel of the 1750 unit to ensure that the properly rated fuse is in place, otherwise damage to the unit is possible. Refer to paragraph 1.4.3.

The 1750 LCR Digibridge unit is shipped with a standard U.S. power cord, QuadTech P/N 4200-0300 (with Belden SPH-386 socket or equivalent and a 3-wire plug conforming to IEC 320). CE units are shipped with an approved international cord set. Make sure the instrument is only used with these cables (or other approved international cord set) to ensure the instrument is provided with connection to protective earth ground.
The surrounding environment should be free from excessive dust to prevent contamination of electronic circuits. The surrounding environment should also be free from excessive vibration. Do not expose the 1750 instrument to direct sunlight, extreme temperature or humidity variations or corrosive chemicals.

## WARNING

If this instrument is used in a manner not specified in this manual protection to the operator and equipment may be impaired.

## Section 2: Operation

### 2.1 Terms and Conventions

Table 2-1: Measurement Unit Prefixes

| Multiple | Scientific | Engineering | Symbol |
| :--- | :--- | :--- | :--- |
| 1000000000000000 | $10^{15}$ |  |  |
| 1000000000000 | $10^{12}$ | Peta | P |
| 1000000000 | $10^{9}$ | Tera | T |
| 1000000 | $10^{6}$ | Giga | G |
| 1000 | $10^{3}$ | Mega | M |
| .001 | $10^{-3}$ | Kilo | k |
| .000001 | $10^{-6}$ | milli | m |
| .000000001 | $10^{-9}$ | micro | u |
| .000000000001 | $10^{-12}$ | nano | n |
| .000000000000001 | $10^{-15}$ | pico | p |
|  |  | femto | f |

Dielectric Absorption: The physical phenomenon in which insulation appears to absorb and retain an electrical charge slowly over time. Apply a voltage to a capacitor for an extended period of time, then quickly discharge it to zero voltage. Leave the capacitor open circuited for a period of time then connect a voltmeter to it and measure the residual voltage. The residual voltage is caused by the dielectric absorption of the capacitor.

Charging Current: An insulated product exhibits the basic characteristics of a capacitor. Application of a voltage across the insulation causes a current to flow as the capacitor charges. This current instantaneously rises to a high value as voltage is applied then exponentially decays to zero as the DUT becomes fully charged. Charging current decays to zero much faster than dielectric absorption.

Leakage Current:
The steady state current that flows through the insulation. Leakage current is equal to the applied voltage divided by the insulation resistance. Leakage current is the main measured value for AC hipot and DC hipot.

| Discharge: | The act of draining off an electrical charge to ground. <br> Devices that retain charge should be discharged after an IR <br> or DC hipot test. |
| :--- | :--- |
| Frequency: | The rate at which current or voltage reverses polarity and <br> then back again completing a Full cycle, measured in Hertz <br> (Hz) or cycles/second. AC Line Frequency = $50 / 60 \mathrm{~Hz}$. |
| Ground: | The base reference from which voltages are measured, <br> nominally the same potential as the earth. Ground is also <br> the side of a circuit that is at the same potential as the base <br> reference. |
| Inductance: | Inductance is the property of a coil to oppose any change in <br> current through it. The inductance of a coil varies as the <br> number of turns squared (N ${ }^{2}$ ). If the turns are stretched out, <br> the field intensity will be less and the inductance will be |
| less. The larger the radius or diameter of the coil, the |  |
| longer the wire used and the greater the inductance. |  |



Figure 2-1: Impedance and Admittance Phase Diagrams \& Equivalent Circuits

### 2.2 Startup

Check to make sure the line voltage selector on the rear panel of the 1750 Digibridge instrument agrees with the AC power source available, if not refer to paragraph 1.4.3.

Connect the 1750 instrument AC power cord to the source of proper voltage. The instrument is to be used only with 3-wire grounded outlets.

```
    WARNING
    When the BIAS ON LED is ON or flashing, there is High Voltage present at the UNKNOWN (H}\mp@subsup{H}{\mathrm{ POT & H }}{\mathrm{ CUR }
```


### 2.3 System Parameters

The system parameters of the 1750 Digibridge are illustrated in Figure 1-1, sections 9(ap) and 3(a-c) and are enlarged in Figure 2-2 for clarity. Paragraphs 2.3.1 through 2.3.12 describe the functions of these parameters.



Figure 2-2: 1750 System Parameters (Front Panel View)

### 2.3.1 A DISP (A Display)

The [A DISP] button allows the user to select the primary measurement parameter equal to $\mathrm{L}, \mathrm{C}, \mathrm{R}$ or $|\mathrm{Z}|$. The corresponding LED will light and the appropriate unit LED will light.

### 2.3.2 RATE

The [RATE] button allows the user to select the measurement rate equal to Slow, Fast or Medium. The default measurement rate of the 1750 instrument is Fast mode.

| Measurement <br> Rate | Measurement Frequency |  |  |  |  |  |  |  |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- | :---: |
|  | 20 Hz | 100 Hz | 120 Hz | 1 kHz | 10 kHz | 100 kHz | 200 kHz |  |
| Slow | 900 mS | 630 mS | 630 mS | 580 mS | 580 mS | 610 mS | 610 mS |  |
| Medium | 880 mS | 194 mS | 164 mS | 140 mS | 135 mS | 135 mS | 133 mS |  |
| Fast | 880 mS | 194 mS | 164 mS | 67 mS | 65 mS | 65 mS | 63 mS |  |

### 2.3.3 AUTO

The [AUTO] button allows the user to select the AUTO measurement mode ON or OFF. If AUTO is enabled, the corresponding LED will light under the A Display. Press [AUTO] a second time to return to manual mode. The A Display briefly shows the measurement range ("rG--2"). The range is then shown in the Bin No display (" 2 ").

### 2.3.4 RANGE

The [RANGE] button allows the user to manually select the measurement range equal to Range 1 through Range 7. Range availability is dependent upon test frequency. If the user selects a range out of specification with the device being measured the A and B displays will contain four half zero's denoting the measured parameter has exceeded the range limit.


### 2.3.5 B DISP (B Display)

The [B DISP] button allows the user to select the secondary measurement parameter equal to $\mathrm{Q}, \mathrm{D}, \mathrm{R}$ or $\theta$. The corresponding LED will light and the appropriate unit LED will light.

### 2.3.6 CKT.: PAR. \& SER.

The equivalent circuit is selected by pressing [PAR.] for parallel or [SER.] for series. The corresponding PAR or SER LED will light indicating the equivalent circuit.

### 2.3.7 ZERO: OPEN \& SHORT

Enable the Zero function by connecting the test cables in 'open' configuration and pressing [OPEN] then [TRIG] or by connecting the test cables in 'short' configuration and pressing [SHORT] then [TRIG]. If a FAIL message is displayed the 1750 instrument will ignore the [ZERO] data. Reconnect cables and try the [ZERO] function again. Refer to Figure 2-3 for the Kelvin Clip Leads Open \& Short Configuration.

For R or L measurements, connect a short across the test cables or fixture then press the ZERO [SHORT] button. When enabled in R or L measurements, the Zero function removes the effects of any series resistance or inductance of the test cabling or fixture.

For C measurements, connect the test cables or fixture in 'open' configuration then press the ZERO [OPEN] button. When enabled in C measurements, the Zero function removes the effects of any stray capacitance or conductance of the test cabling or fixture.

## NOTE:

If OPEN and SHORT calibration fails, the RAM memory may need to be reset. To reset the memory: Press [PROG] [SHIFT] [SPECIAL] [9] [=] [1] [9] [9] [9] [1] [0] [7] [5]. Turn power off then on.

Capacitance shielded wire should be used for cables to minimize any resonance effects in the measurement of large inductance. Test fixture extension cable can add some capacitance in parallel with the DUT due to imperfect shielding of the leads. The Zero function will compensate for capacitance between cables under normal test conditions.


Figure 2-3: Kelvin Clip Leads: Open \& Short Configuration

| NOTE |
| :---: |
| Anytime the test cables or test fixture are changed, the 1750 instrument should be re-zeroed. |

### 2.3.8 BIAS

The [BIAS] button allows the user to select the external bias function ON or OFF. When the external bias is enabled the BIAS ON LED will be lit. Connection of the external source is through the single BNC terminal on the rear panel. Bias is not floating it is connected to instrument ground. The positive (+) connector is the center of the BNC and the negative $(-)$ connector is the BNC shield. Bias range is $0-35 \mathrm{~V}$.

### 2.3.9 LOCAL

When the 1750 instrument is used in REMOTE mode (IEEE-488 or Handler interfaces) pressing the [LOCAL] button allows the user to operate the instrument using the front panel controls.

## NOTE

If the local lockout command (LLO) is sent over the IEEE-488 bus, the [LOCAL] button is INOPERATIVE.

### 2.3.10 V/I/F

The [V/I/F] button allows the user to select the parameter to be shown on the PRESET display. The user can preset the test voltage (V) or test frequency ( F ) and monitor output current (I) through the DUT. The [V] LED will light when the test voltage is set. The test voltage range is 0.01 V to 2.50 V in 0.01 V steps and the instrument default value is last powered down test voltage. The $[\mathrm{Hz}]$ or $[\mathrm{kHz}]$ LED will light when the test frequency is set. There are 42 preset test frequencies from 20 Hz to 200 kHz or the user can program a specific frequency as in $\mathbb{I} 2.4 .23$. The instrument frequency default value is last powered down test frequency. The [mA] LED will light when the output current is displayed.

### 2.3.11 STEP

The [STEP] [ $\mathbf{\nabla}$ ] and [ $\mathbf{\Delta}$ ] buttons allow the user to toggle through the instrument preset test voltages or test frequencies. Use the [V/I/F] button to select parameter then use the [STEP] [ $\mathbf{\nabla}$ ] or [ $\mathbf{\Delta}$ ] to select test voltage or frequency.

### 2.3.12 TRIGGER

The TRIGGER function of the 1750 instrument allows the user to select an external (EXT) or internal (INT) machine trigger. Press the [EXT./INT] button to enable the external trigger and the red LED above the [EXT./INT] button will light. Press the [TRIG] button to initiate measurement when the instrument is used in REMOTE mode.

### 2.4 Program Parameters

The programming parameters of the 1750 Digibridge instrument keypad are illustrated in Figure 1-1, section 4(a-t) and are enlarged in Figure 2-4 for clarity. Paragraphs 2.4.1 through 2.4.24 describe the functions of these parameters.


Figure 2-4: Programming Parameters

### 2.4.1 PROG/ESC

The [PROG/ESC] button allows the user to enter and exit programming mode. Press [PROG/ESC] to enter programming mode. The A DISPLAY flashes the word 'Prog". The blue labeled buttons are functional in programming mode. Press [SHIFT] to select a programming parameter labeled in red or press [PROG/ESC] to exit programming mode. Table 2-2 lists the programming keys by color. Blue are functional in programming mode, red are functional after [SHIFT] has been pressed and grey are functional at all times. The [PROG/ESC] button is also used to escape from [STORE] or [RECALL] functions.

Table 2-2: Programming Keys

| Blue Keys | Red Keys | Grey Keys |
| :--- | :--- | :--- |
| PROG/ESC | SHIFT | STORE |
| ENTER | SPECIAL | RECALL |
| CLEAR | CONSTANT | VOLT |
| $\%$ | ADDR | FREQ |
| 1234567890 | UNIT |  |
| - | NOM. VAL |  |
| LOCK | BIN NO. |  |
| $=$ | LOAD |  |
|  | AVERAGE |  |
|  | CAL |  |
|  | $\theta$ NOM |  |

### 2.4.2 STORE

The [STORE] button allows the user to the present set of test conditions in one of 10 internal instrument memory locations. Press [STORE] and enter the memory location number (0-9) in which to store the present test conditions. Press [ENTER] to accept.

| Press [BUTTON] | Display will show: |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| [STORE] |  | $\begin{array}{lll}\circ & 0 \\ \therefore & 0 \\ \therefore & 0 \\ 0 & 0\end{array}$ | Stor_ | - | - $\begin{array}{r}\text {-G0 } \\ -N G\end{array}$ | 120 | kHz |
| [=] [2] | $$ | $\begin{array}{lll}\circ & 0 \\ \therefore & 0 \\ \therefore & 0 \\ 0 & 0\end{array}$ | Stor_ | 2 | - $\begin{array}{r}\text { - G0 } \\ -N G\end{array}$ | 120 | kHz |
| [ENTER] |  | $\begin{array}{lll}\therefore & 0 \\ \therefore & 0 \\ \therefore & \\ 0 & 0 \\ 0 & 0\end{array}$ |  | 2 | - $\begin{array}{r}\text { - GO } \\ -N G\end{array}$ | 120 | kHz |

### 2.4.3 RECALL

The [RECALL] button allows the user to recall a set of test conditions in one of 10 internal instrument memory locations. Press [RECALL] and enter the memory location number (0-9) from which to recall a specific test condition. Press [ENTER] to accept.


### 2.4.4 SPECIAL

The [SPECIAL] button allows the user to access special functions within the programming mode. Press [PROG/ESC], [SHIFT] then [SPECIAL] to access the special functions listed in Table 2-3.

Table 2-3: [SHIFT] [SPECIAL] Function List

| Press Program [Buttons] | Function |
| :--- | :--- |
| [SHIFT] [SPECIAL] [2] | Select Single or Multi Frequency Open/Short Zero Function |
| [SHIFT] [SPECIAL] [4] | Select 1320 BCS Measurement Link Function |
| [SHIFT] [SPECIAL] [7] | Select Measurement Range Display Function |
| [SHIFT] [SPECIAL] [8] | Select Median Value Display Function |

### 2.4.4.1 Multi-Frequency Open/Short Zero

When activated, the Multi-Frequency Open/Short Zero function permits the user to change test frequencies without having to re-zero the 1750 instrument. To activate this function, press [PROG/ESC], [SHIFT], [SPECIAL] then [2]. Press [=] to switch from Single Frequency to Multi-Frequency. Press [ENTER] to accept data entry. Press [PROG/ESC] to exit.

### 2.4.4.2 1320 BCS Measurement Link

When the 1320 Bias Current Source instrument is linked to the 1750 instrument, setting this function ON enables OPEN Zeroing and faster measurement. To activate this function, press [PROG/ESC], [SHIFT], [SPECIAL] then [4]. Press [=] to turn the link ON or OFF. Press [ENTER] to accept data entry.

### 2.4.4.3 Measurement Range Display

When the Comparison Function is disabled (NOMinal VALue is set to 0), activating the Measurement Range Display function permits the user to display the Measurement Range in the BIN NO Display. To activate this function, press [PROG/ESC], [SHIFT], [SPECIAL] then [7]. Press [=] to turn range display ON or OFF. Press [ENTER] to accept data entry.

### 2.4.4.4 Median Value Display

When activated, the 1750 instrument makes three (3) measurements, computes the median value and displays the median value with judgment. To activate this function, press [PROG/ESC], [SHIFT], [SPECIAL] then [8]. Press [=] to turn median value display ON or OFF. Press [ENTER] to accept data entry.

### 2.4.5 ENTER

The [ENTER] button permits the user to accept the data entered in programming mode.

### 2.4.6 CLEAR

The [CLEAR] button permits the user to clear the data currently being entered in programming mode before the [ENTER] button is pressed.

### 2.4.7 CONSTANT

The [CONSTANT] button permits the user to specify a constant output source resistance. In LCR testing, the output impedance of the source can be fixed at $25 \Omega$ or $100 \Omega$. For a DUT that has variable impedance, select CONSTANT OFF for improved accuracy. The instrument default value is OFF. To select CONSTANT, press [PROG/ESC], [SHIFT] then [CLEAR]. The display will flash "ConSt OFF 0". Press [=] [1] to select $25 \Omega$. Press [=] [2] to select $100 \Omega$. Press [=] [0] to select CONSTANT OFF. Press [ENTER] to accept data input.

Press [BUTTON]
[PROG/ESC]
[SHIFT]
[CLEAR]
 $\Omega$




## Display will show:



120

120
$\qquad$ kHz
[2]
$\Omega$

120


### 2.4.8 \% (Percent Value)

The [\%] button permits the user to specify that the displayed value is a percent value rather than an absolute value.

### 2.4.9 ADDR (IEEE-488 Address)

The [ADDR] button permits the user to specify the IEEE-488 address. The instrument range is $0-30$ and the default value is 3 . To select the Address, press [PROG/ESC], [SHIFT] then [ADDR]. Press [=], [number of address] then [ENTER] to accept the input.

Press [BUTTON]
[PROG/ESC]
[SHIFT]
[ADDR]
[=]
[5]
[ENTER]

Display will show:

$M \Omega$


120


120

### 2.4.10 $=$ (Equal Sign)

The [=] button permits the user to change the present test condition. In programming mode, the $[=]$ button must be pressed to change a value. For example, press [PROG/ESC], [SHIFT], [Test Parameter to be changed], [ $=$ ] then enter the new value and press [ENTER] to accept data input.

### 2.4.11 UNIT

The [UNIT] button permits the user to change the A DISPLAY parameter unit. The [UNIT] button is only functional in programming mode when a nominal value or load correction value is being entered. Refer to paragraphs 2.4.13 and 2.4.17 respectively.

### 2.4.12 SHIFT

The [SHIFT] button permits the user to select a test parameter to change in programming mode. All programming parameters labeled in red are functional after pressing the [SHIFT] button. These parameters are CONSTANT, ADDR, UNIT, NOM. VAL, BIN NO., BIN SUM, DELAY, LOAD, AVERAGE, CAL, RANGE, DEFAULT and $\theta$ NOM. The [SHIFT] button is functional only after pressing the [PROG/ESC] button first.

### 2.4.13 NOM. VAL (Nominal Value)

The [NOM. VAL] button permits the user to enter a nominal value for the primary parameter which is the basis for the measurement result in $\Delta$ or $\Delta \%$. To enter a nominal value, press [PROG/ESC], [SHIFT] then [NOM. VAL]. The display will flash ".0000, -non-". Press [=] and enter the nominal value of the primary parameter. Once in [NOM. VAL], the nominal value unit can be changed by pressing [SHIFT] then [UNIT] until the corresponding unit LED lights next to the A DISPLAY. Then enter the nominal value of the primary parameter and press [ENTER] to accept.


### 2.4.14 BIN NO. (Bin Number)

The [BIN NO.] button permits the user to assign a nominal value to a bin number for sorting of DUT pass/fail results. There are 10 bins available. Bin $0-9$ are PASS bins for the primary parameter. To select a bin number, press [PROG/ESC], [SHIFT], [BIN NO.], [assigned bin \#], [=], [limit (\% value) of primary parameter] then [ENTER] to accept data input.

## Press [BUTTON]

[PROG/ESC]
[SHIFT]
[BIN NO.]
[=]
[2]


120

\%

$\square$
2.4471 M $\Omega$ $\square$
2.4777


### 2.4.15 BIN SUM (Bin Summary)

The [BIN SUM] button permits the user to summarize bin results. Press [PROG/ESC], [SHIFT] then [BIN SUM]. Press the bin number to summarize. The B DISPLAY will show the number of PASS results in the selected bin. To RESET all SUMS to 0 press [SHIFT] [BIN SUM] [CLEAR].

| Press [BUTTON] | Display will show: |  |  |  |  | $\stackrel{\square}{\circ} \mathrm{GO}$ | 120 kHz |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| [PROG/ESC] |  | $\Omega$ | $\begin{array}{ll}\circ & 0 \\ \therefore 0 \\ \therefore 0 \\ \therefore 0\end{array}$ |  |  |  |  |  |
| [SHIFT] | $$ | $\Omega$ | $\begin{array}{ll}\circ & 0 \\ \therefore 0 \\ \therefore 0 \\ \therefore 0 \\ 0 & 0\end{array}$ |  |  | - $\begin{array}{r}\circ \\ 0 \\ 0 \\ 0\end{array}$ | 120 | kHz |
| [BIN SUM] | (1) | $\Omega$ |  |  | -- | - $\begin{array}{r}\circ \\ 0 \\ 0 \\ 0\end{array}$ | 120 | kHz |
| [=] |  | $\Omega$ | $\begin{array}{ll}\circ & 0 \\ \therefore & 0 \\ \therefore & 0 \\ 0 & 0\end{array}$ |  | -- | - $\begin{array}{r}\text { O GO } \\ 0 \\ 0\end{array}$ | 120 | kHz |
| [3] | ( |  |  | 0 | 3 | $\circ$ 0 0 0 | 120 | kHz |
| [PROG/ESC] [PROG/ESC] |  |  | $\begin{array}{ll}\circ & 0 \\ \therefore 0 \\ 0 & 0 \\ \therefore 0\end{array}$ | 2.4756 | 0 | - GO | 120 | kHz |

### 2.4.16 LOCK (Key Lock)

The [LOCK] button permits the user to lock out the front panel. Press [PROG/ESC] then [LOCK] to lock out red programming parameters. The KEY LOCK LED is lit when the LOCK is enabled. Press [PROG/ESC] then [LOCK] to disable lock out.

### 2.4.17 LOAD (Load Correction)

The [LOAD] button permits the user to specify a value of the component under test (user supplied standard) and apply a correction to subsequent measurements of similar components under the same test conditions. Same test conditions are defined as same test voltage, test frequency and measurement rate. Press [PROG/ESC], [SHIFT] then [LOAD]. Press [=] and [number of bin load applies to]. Press [ENTER] to accept data input. To change unit, press [=], [UNIT], [enter value of load]

Press [BUTTON]
[PROG/ESC]
[SHIFT]
[LOAD]
[=] [2]
[ENTER]
[=] [UNIT]
[2] [.] [5] [0] [0]
[ENTER]

Display will show:
 $M \Omega$


120


120

### 2.4.18 AVERAGE

The [AVERAGE] button permits the user to specify the number of measurements to average from $0-10$. The instrument default value is 0 . For example set AVERAGE=10. The 1750 instrument will make 10 measurements and then display the average value. The unit will continue to take 10 measurements and display the average until the average function is disabled. To select the average function, press [PROG/ESC], [SHIFT] then [AVERAGE]. Press [ $=$ ], [\# of measurements to average] then [ENTER] to accept data input.

Press [BUTTON]
Display will show:
[PROG/ESC]
[SHIFT]


120

[5]


### 2.4.19 VOLT (Test Voltage)

The [VOLT.] button permits the user to specify the test voltage from 0.01 V to 2.50 V in 0.01 V steps. The instrument default value is the last test setup value. Press [VOLT.]. The PRESET DISPLAY will flash. Using the numerical and decimal keys, enter the test voltage in volts from $0.01-2.50 \mathrm{~V}$. Press [ENTER] to accept data input.

| Press [BUTTON] | Display will show: |  |  |  |  | - ${ }_{-} \mathrm{GO}$ | --- |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| [VOLT.] |  | м $\Omega$ | $\begin{array}{ll}\circ & 0 \\ 0 & 0 \\ \therefore 0 \\ 0 & 8 \\ 0\end{array}$ | 2.7664 |  |  |  |
| [2] [.] [5] [0] | ( | м $\Omega$ |  | 2.7664 | 0 | - Go $-N G$ | 2.50 |
| [ENTER] |  |  |  | 2.5475 | 0 | - Go -Na | 2.50 |

### 2.4.20 CAL (Calibration)

The [CAL] button permits the user to enter instrument calibration mode. Press [PROG/ESC], [SHIFT], then [CAL] to enter calibration. Refer to paragraph 4.3 for a full description of calibration. Instrument calibration should be performed by qualified service technicians.

### 2.4.21 $\Delta$ (Deviation from Nominal)

The [ $\Delta$ ] button permits the user to specify that the measurement results be displayed as the deviation from the set nominal value ( $\mathbb{I}$ 2.4.13). Press [ $\Delta$ ] to enable the deviation function. The corresponding $\Delta$ LED will light.

### 2.4.22 $\Delta \%$ (Percent Deviation from Nominal)

The [ $\Delta \%$ ] button permits the user to specify that the measurement results be displayed as the percent deviation from the set nominal value (II 2.4.13). Press [ $\Delta \%$ ] to enable the deviation percent deviation function. The corresponding $\Delta \%$ LED will light.

### 2.4.23 FREQ (Test Frequency)

The [FREQ.] button permits the user to specify the test frequency from 20 Hz to 200 kHz . The instrument default value is the last test setup value. Press [FREQ.]. The PRESET DISPLAY will flash. Using the numerical and decimal keys, enter the test frequency in Hertz from $0.02-200 \mathrm{kHz}$. Press [ENTER] to accept data input.

Press [BUTTON] Display will show:

```
[FREQ.]
```

[1] [2] [2]
[ENTER]


## NOTE

The $\mathbf{5 0 0}$ programmable frequencies are derived using the following equation:
$\mathrm{f}=\frac{\mathrm{n}}{\left(2^{30}\right)} \cdot 38.4 \mathrm{MHz}$
Where: 559 < n < 5592405
$(20 \mathrm{~Hz}) \quad(200 \mathrm{kHz})$

### 2.4.24 $\boldsymbol{\theta}$ NOM ( $\theta$ Nominal Value)

The [ $\theta$ NOM.] button permits the user to specify a nominal value for $\theta$ (the phase angle). $\theta$ must be selected as the secondary parameter on the B DISPLAY first before specifying a $\theta$ NOM value. Press [PROG/ESC], [SHIFT] then [ $\theta$ NOM.]. The display will flash "-dE9-, $.0000 "$. Press $[=]$, [value of $\theta$ NOM in $\left.{ }^{\circ}\right]$ then [ENTER] to accept data input.

Press [BUTTON]
[PROG/ESC]
[SHIFT]
[0 NOM.]
[=]
 м $\Omega$
120

### 2.5 Connection to Device Under Test

Figure 2-5 illustrates the connection of a device under test to the 1750 instrument using the $4-$ BNC to 2 -Kelvin Clip cable lead set. This cable set (QuadTech P/N 1700-03) is supplied with the 1750 LCR Digibridge unit.


Figure 2-5: Connection to Device Under Test (DUT)


Figure 2-6: 4-BNC to 2-Kelvin Clip Leads (1700-03)

Other connectors are available as optional accessories for the 1750 Digibridge and are listed in Table 2-3.

Table 2-3: 1700 Series Digibridge Accessories

| Accessory | QuadTech P/N | Figure \# |
| :--- | :--- | :--- |
| Axial/Radial Component Test Fixture | $1700-01$ | $2-7$ |
| Axial/Radial Remote Component Test Fixture | $1700-02$ | $2-8$ |
| 4-BNC to 2-Kelvin Clip(s) Lead Set | $1700-03$ | $2-6$ |
| 4-BNC to 4-Banana Plug(s) Lead Set | $1700-04$ | $2-9$ |
| 4-BNC to Chip Component Tweezers | $1700-05$ | $2-10$ |



Figure 2-7: Axial/Radial Component Test Fixture (1700-01)


Figure 2-8: Axial/Radial Remote Test Fixture (1700-02)


Figure 2-9: 4-BNC to 4-Banana Plug(s) Lead Set (1700-04)


Figure 2-10: 4-BNC to Chip Component Tweezers (1700-05)

### 2.6 Measurement Procedure

The 1750 Digibridge instrument has continuous and triggered measurement capability. Continuous mode is the normal instrument operation mode as described in paragraph 2.6.1. Trigger mode is employed when the instrument is remotely operated via the IEEE488 or Handler interfaces. Refer to paragraphs 3.1 and 3.2 respectively.

### 2.6.1 Continuous Measurement Mode

1. Turn POWER ON.
2. Allow the 1750 instrument to warm-up for 15 minutes.
3. Select Primary Parameter.
4. Select Frequency.
5. Select Test Voltage.
6. Select Measurement Range.
7. Select Measurement Rate.
8. Select Secondary Measurement.
9. Select Equivalent Circuit (Series or Parallel).
10. Connect Test Cables or Test Fixture ( $\mathbb{I} 2.5$ ).
11. Enable Zero Function ( $\Psi[2.3 .7$ ).
12. Connect Device Under Test (DUT) ( $4[2.5$ ).

The 1750 Digibridge will continually test until the DUT is disconnected. When the test leads or test fixture are changed, enable the Zero Function to compensate for series resistance and inductance or stray capacitance and conductance.

## CAUTION

When testing capacitive devices using a Bias Voltage applied at the rear panel input terminals, use extreme caution. The charge stored in the capacitor can be lethal if the device is not allowed enough discharge time.

### 2.6.2 Trigger Measurement Mode

1. IEEE-488 Interface is connected via rear panel to external computer (II 3.1).
2. Talk/Listen DIP Switch is in appropriate position (II 3.1.2).
3. Press [EXT./INT] button so that the red LED lights (indicating EXT Trigger).
4. Connect DUT to 1750 UNKNOWN terminals ( $(22.5)$.
5. Press [TRIG] button to initiate triggered measurement.

### 2.7 BIN SORTING (Comparison Function)

### 2.7.1 Binning Description

If a group of similar components are to be measured, it is convenient to use the limit comparison function of the 1750 instrument to categorize the components. For an example the 1750 instrument can be used to sort a group of nominally-valued 100 nF capacitors into bins of $1 \%, 2 \%, 5 \%, 10 \%$, lossy rejects and other rejects. The bin assignment is displayed on the BIN NO. display for guidance in hand sorting. If the HANDLER interface is activated the components are output automatically to a HANDLER for mechanized sorting.

The 1750 instrument has 10 bins for component sorting. Bins 1-9 are PASS bins for the primary parameter ( $\mathrm{L}, \mathrm{C}, \mathrm{R} \& \mathrm{Z}$ ). Bin 9 is the FAIL bin for the primary parameter ( $\mathrm{L}, \mathrm{C}$, $\mathrm{R} \& \mathrm{Z}$ ) when the primary is out of range of all bin limits. Bin 0 is the FAIL bin for the secondary parameter ( $\mathrm{D}, \mathrm{Q}, \mathrm{R} \& \theta$ ).

Manually entered limits are normally entered in pairs to define the upper and lower limits of a bin. Limits are entered in the form of "nominal value" and "percent" above and below that nominal value. To set a symmetrical limit (such as $\pm 5 \%$ ) enter one "percent" value. To set a non-symmetrical pair of limits enter two "percent" values.

For a simple GO/NO-GO test, set a DQR limit in one regular bin (1-9). Entry in additional bins will define additional GO conditions. Make sure the unused bins are closed. Bins $0-9$ are initially zero at power-up. The default $\operatorname{DQR} \theta$ limit is "all FAIL" for D , Rs and $\theta$. The default $\mathrm{DQR} \theta$ limit is "all PASS" for Rp or Q . Bins 1-9 are initially closed.

### 2.7.2 Sorting Sequence

The secondary parameter ( $\mathrm{D}, \mathrm{Q}, \mathrm{R} \& \theta$ ) is compared first in the sorting sequence. If the measured value compared with the limit of BIN 0 is NO GOOD (D or Rs is higher, Q or Rp is lower and/or $\theta$ is out of range) it will be sorted in BIN 0 and judged NG even if the primary parameter is in range. If the compared result is GOOD, the primary measured value ( $\mathrm{L}, \mathrm{C}, \mathrm{R} \& \mathrm{Z}$ ) will be compared with the limits of BINS 1 through 9 in regular sequence and sorted in the first bin range limit it meets. If the measured value is out of range of all the bin limits, it will be sorted in BIN 9 (fail) and judged NG. Figure 2-11 illustrates the 1750 instrument's sorting sequence.


Figure 2-11: Bin Sorting Sequence

### 2.7.3 Binning Procedure

Before setting bin limits, set the measurement conditions as follows:
1 Select primary parameter [A DISPLAY]
2 Select secondary parameter [B DISPLAY]
3 Select test frequency and voltage [V / I / F]
4 Select equivalent circuit [SERIES] or [PARALLEL]
5 Select measurement range [RANGE]
6 Select measurement rate [RATE]
7 Select trigger mode [EXT./INT]
Now set the bin limits.
1 Set the secondary parameter limit (BIN 0 ). The upper limit is for D and Rs. The lower limit is for $Q$ and Rp. If $|Z|$ or $\theta$ is to be measured, set the $\theta$ NOM value first then the BIN 0 limit value. The tolerance of $\theta$ is $(\theta \operatorname{NOM} \pm \operatorname{BIN} 0)$.

2 Set the nominal value ([NOM VAL]) including value and unit.

3 Set the percentage bin limits for BINS 1-9.
The flow chart in Figure 2-12 and Table 2-4 illustrate the Bin limit entry procedure. In the flow chart the symbol 0 represents the phase angle $\theta$.

## NOTE

Pressing the [PROG/ESC] button before Step \#4 will exit the user from programming mode. In Step \#5, press the [PROG/ESC] button to return to STEP \#3 and the entered value will be ignored. Press [CLEAR] to clear the entered value and re-enter correct value.


Figure 2-12: BIN Limit Entry Flowchart

Table 2-4: BIN Limit Entry Procedure

| Step \# | Operation | Description | A DISPLAY | B DISPLAY |
| :--- | :--- | :--- | :--- | :--- |
| 1 | $[P R O G / E S C]$ | Enter Programming Mode | "Prog" |  |
| 2 | $[$ SHIFT $]$ | Enable "red" buttons | "SHFt" |  |
| 3 | $[$ NOM. VAL $]$ | Select Nominal Value | Last set value | "-non-" |
|  | $[\theta$ NOM $]$ | Select $\theta$ NOM Value | "-dEg-" | Last set value |
|  | $[$ BIN NO. $]+[\theta]$ | Select Secondary Parameter limit | "-bin-" | Last set value |
| 4 | $[=]$ | Change value of selected function | Last set value | Flashing cursor |
| 5 | $[$ Numerical keys $]$ <br> $[$ UNIT] $]$ | Enter value first <br> Change unit if necessary | Selected <br> Function | Value Entered <br> Flashing cursor |
| 6 | $[$ ENTER] | Accept value entered | Same as Step \#3 |  |
| 7 | $[$ RROG/ESC $]$ | Exit Programming Mode | Return to Measurement Mode |  |

### 2.7.4 Binning Example

Figure 2-13 illustrates the sorting reference for a group of capacitors having a nominal value of $\mathrm{Cs}=0.1 \mu \mathrm{~F}$ and $\mathrm{D} \leq 0.01$. The bin symmetrical limits are $\pm 1 \%, \pm 2 \%, \pm 5 \%$, $\pm 10 \%,+20 \%$ and $-80 \%$. BIN 0 is for components with a measured D value (absolute value) that is greater than 0.01 .


Figure 2-13: Capacitor Example Symmetrical Sorting Reference
Program the example as follows:
1 Press [SER.] to select equivalent circuit $=$ SERIES
2 Press [A DISP] to select primary parameter $=\mathrm{C}$
3 Press [B DISP] to select secondary parameter $=\mathrm{D}$
4 Press [V / I / F] to set test frequency and test voltage
5 Press [PROG/ESC] to enter programming mode

6 Press [SHIFT] to enable 'red' labeled functions
7 Press [BIN NO.] [0] [=] [0] [.] [0] [1] [ENTER] to enter D limit $=0.01$
8 Press [SHIFT] to enable 'red' labeled functions
9 Press [NOM. VAL] [=] [0] [.] [1] [UNIT until ( $\mu \mathrm{F}$ ) LED is lit] [ENTER] to enter $\mathrm{C}=0.1 \mu \mathrm{~F}$
10 Press [SHIFT] to enable 'red' labeled functions
11 Press [BIN NO.] [1] [=] [1] [ENTER] to set BIN 1 limits $= \pm 1 \%$
12 Press [SHIFT] to enable 'red' labeled functions
13 Press [BIN NO.] [2] [=] [2] [ENTER] to set BIN 2 limits $= \pm 2 \%$
14 Press [SHIFT] to enable 'red' labeled functions
15 Press [BIN NO.] [3] [=] [5] [ENTER] to set BIN 3 limits $= \pm 5 \%$
16 Press [SHIFT] to enable 'red' labeled functions
17 Press [BIN NO.] [4] [=] [1] [0] [ENTER] to set BIN 4 limits $= \pm 10 \%$
18 Press [SHIFT] to enable 'red' labeled functions
19 Press [BIN NO.] [5] [=] [2][0] [\%] [-] [8] [0][ENTER] to set BIN 5 limits $=+20 \%$ and $-80 \%$.
20 Press [SHIFT] to enable 'red' labeled functions
21 Press [BIN NO.] [6] [=] [ENTER] to CLOSE BIN 6 (if it was previously open)
22
Press [PROG/ESC] to exit programming mode

### 2.7.5 Comparison Notes

The Comparison Function is enabled when the nominal value is set to a non-zero value. If the Comparison Function is enabled, the sorted bin \# will be displayed on the BIN NO display and the corresponding judgment GO/NG LED will light. If the buzzer is ON (silver knob rear panel) it will continue to sound when GO is the judgment. To inhibit the comparison function set the nominal value equal to zero. The GO/NG LED indicators do not function and the BIN NO. display shows the measurement range.

The $\Delta$ (deviation from nominal) and $\Delta \%$ (percent deviation from nominal) can be displayed when the Comparison Function is enabled. Press $[\Delta]$ or $[\Delta \%]$ to select the display to show the deviation from nominal as an absolute or percent value.

At power up conditions, BINS 1-9 are initially closed so the instrument ignores the unused bins. Every unused bin must be closed by entering 0\% as in Step 21, g[2.7.4. Once a bin is closed, it remains closed until a non-zero percent limit is entered.

The limit entered for BIN 0 is either the upper or the lower limit for the secondary measurement parameter ( $\mathrm{D}, \mathrm{Q}, \mathrm{R} \& \theta$ ). The upper/lower limit selection depends on the equivalent circuit selection:

Lower: $\quad \mathrm{Q}, \mathrm{Rp}(\mathrm{R}$ in Parallel circuit)
Upper: $\quad \mathrm{D}, \mathrm{Rs}$ ( R in Series circuit)
Tolerance: $\quad \theta$ (From Nominal $\theta$ value)

When entering the primary bin limits use the [UNIT] button to change the unit of the value being entered. It is recommended to put a standard DUT in the test fixture prior to setting bin limits. The 1750 instrument will use the DUT as a reference unit during the bin limit entry procedure. Make sure that the number entered for nominal value or R limit is suited to the units on the 1750 front panel. (Ex.: 10nF equals 0.01 uF )

### 2.7.6 GO/NG Results

If the Comparison Function (Binning) is enabled (nominal value is set to a non-zero value), the GO/NG LED indicators will function.

The GO LED lights when the DUT PASSES and DUT is put in BINS 1-9.
The NG LED lights when the DUT FAILS and DUT is put in $\operatorname{BIN} 0(\mathrm{D}, \mathrm{Q}, \mathrm{R}$ or $\theta$ failure) or it is put in BIN 9 (L, C, R or Z failure)

BIN 9 is the primary parameter FAIL bin.
The BIN NO display shows the bin assignment of the DUT.

### 2.7.7 BIN SUM Information

If the Comparison Function (Binning) is enabled, the 1750 instrument automatically keeps totals of the number of measurements assigned to each bin since instrument power up (or reset of the count to zero). The Bin Sums can be called onto the front panel display by pressing [BIN SUM] or they can be sent out over the IEEE- 488 bus. The maximum component count is 99999 pieces/bin. Refer to $\mathbb{T} 2.4 .15$ for instructions on checking BIN SUM results. To RESET all SUMS to 0 press [SHIFT] [BIN SUM] [CLEAR].

### 2.7.8 Measurement Time

When the 1750 instrument is operating in Comparison Mode, the measurement time is longer than that of Measurement Mode. Table 2-5 illustrates the typical Comparison Mode measurement time dependent upon frequency.

Table 2-5: Comparison Mode Measurement Time

| Test Speed | Measurement Frequency |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | 20 Hz | 100 Hz | 120 Hz | 1 kHz | 10 kHz | 100 kHz | 200 kHz |
| Slow | 900 mS | 630 mS | 630 mS | 580 mS | 580 mS | 610 mS | 610 mS |
| Medium | 880 mS | 194mS | 164 mS | 140 mS | 135 mS | 135 mS | 633 mS |
| Fast | 880 mS | 194 mS | 164 mS | 67 mS | 65 mS | 65 mS | 63 mS |

NOTE
If ACQ active on HANDLER Interface, subtract 11 mS for slow speed and 6 mS for fast speed.
If displaying $\Delta$ or $\Delta \%$ value, add 3 to 5 mS .
If results are sent over IEEE- 488 bus, add 3 to 6 mS .

### 2.8 Accuracy of L C R \& Z Measurements

The basic accuracy for impedance $(|Z|)$ and phase angle $(\theta)$ is listed in Table 2-6. If the measurements are made at the Fast rate $(65 \mathrm{mSec} / \mathrm{msmt}$ at 1 kHz$)$ the accuracy figure should be doubled.

Table 2-6: $|\mathbf{Z}|-\theta$ Accuracy

|  |  | Measurement Frequency (Hz) |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| \|Z| |  | $\begin{gathered} 20 \\ \mid \\ 100 \end{gathered}$ | 1k | $\begin{gathered} \hline 2 \mathrm{k} \\ 10 \mathrm{k} \end{gathered}$ | $\begin{array}{\|c\|} \hline 20 \mathrm{k} \\ \mid 00 \mathrm{k} \end{array}$ | $\begin{array}{\|c} \hline 100 \mathrm{k} \\ { }_{200 \mathrm{k}} \end{array}$ |
|  | X $\theta$ | $\begin{aligned} & 1.5 \% \\ & 0.7^{\circ} \end{aligned}$ | $\begin{aligned} & 1.0 \% \\ & 0.4^{\circ} \end{aligned}$ | $\begin{aligned} & 1.5 \% \\ & 0.7^{\circ} \end{aligned}$ | $\begin{array}{\|l} \hline 7.0 \% \\ 4^{\circ} \\ \hline \end{array}$ | $\begin{aligned} & 10.0 \% \\ & 6^{\circ} \\ & \hline \end{aligned}$ |
| $\begin{gathered} 1 \mathrm{M} \\ 100 \mathrm{k} \\ \hline \end{gathered}$ | X <br> $\theta$ | $\begin{aligned} & \hline 0.2 \% \\ & 0.15^{\circ} \\ & \hline \end{aligned}$ | $\begin{aligned} & \hline 0.15 \% \\ & 0.07^{\circ} \\ & \hline \end{aligned}$ | $\begin{aligned} & \hline 0.3 \% \\ & 0.2^{\circ} \end{aligned}$ | $\begin{array}{\|l\|} \hline 1.0 \% \\ 0.6^{\circ} \\ \hline \end{array}$ | $\begin{array}{\|l\|} \hline 2.0 \% \\ 1.2^{\circ} \\ \hline \end{array}$ |
| $\begin{gathered} \text { 100k } \\ 10 \mathrm{k} \end{gathered}$ | X <br> $\theta$ | $\begin{aligned} & 0.15 \% \\ & 0.1^{\circ} \\ & \hline \end{aligned}$ | $\begin{aligned} & \hline 0.15 \% \\ & 0.07^{\circ} \\ & \hline \end{aligned}$ | $\begin{aligned} & \hline 0.3 \% \\ & 0.2^{\circ} \\ & \hline \end{aligned}$ | $\begin{array}{\|l\|} \hline 1.0 \% \\ 0.6^{\circ} \\ \hline \end{array}$ | $\begin{aligned} & \hline 1.0 \% \\ & 0.6^{\circ} \\ & \hline \end{aligned}$ |
|  | X <br> $\theta$ | $\begin{aligned} & 0.1 \% \\ & 0.05^{\circ} \end{aligned}$ | $\begin{array}{\|l\|} \hline 0.1 \% \\ 0.03^{\circ} \\ \hline \end{array}$ | $\begin{aligned} & \hline 0.1 \% \\ & 0.05^{\circ} \\ & \hline \end{aligned}$ | $\begin{array}{\|l\|} \hline 0.15 \% \\ 0.05^{\circ} \\ \hline \end{array}$ | $\begin{array}{\|l\|} \hline 0.2 \% \\ 0.3^{\circ} \\ \hline \end{array}$ |
| $\begin{aligned} & \hline 1 \\ & 1 \\ & 0.1 \end{aligned}$ | X <br> $\theta$ | $\begin{aligned} & 0.15 \% \\ & 0.06^{\circ} \end{aligned}$ | $\begin{aligned} & \hline 0.1 \% \\ & 0.07^{\circ} \end{aligned}$ | $\begin{aligned} & 0.15 \% \\ & 0.06^{\circ} \end{aligned}$ | $\begin{aligned} & 0.2 \% \\ & 0.3^{\circ} \end{aligned}$ | $\begin{aligned} & 0.2 \% \\ & 0.3^{\circ} \end{aligned}$ |
| $\begin{gathered} 0.1 \\ \left.\right\|_{1} \\ 0.01 \end{gathered}$ | X $\theta$ | $\begin{aligned} & \hline 0.5 \% \\ & 0.5^{\circ} \\ & \hline \end{aligned}$ | $\begin{aligned} & 0.2 \% \\ & 0.1^{\circ} \\ & \hline \end{aligned}$ | $\begin{aligned} & 0.5 \% \\ & 0.5^{\circ} \end{aligned}$ | $0.5 \%$ <br> $0.5{ }^{\circ}$ | $1.0 \%$ $2^{\circ}$ |

## L C R Accuracy:

For $Q \geq 10$ ( $\mathrm{D} \leq 0.1$ ), equals accuracy of $|\mathrm{Z}|$ where:
$|\mathrm{ZL}|=|2 \pi \mathrm{fL}|$
$|\mathrm{Zc}|=|1 /(2 \pi \mathrm{fc})|$

For $\mathrm{Q}<10(\mathrm{D}>0.1)$, multiply L accuracy by ( $1+1 / \mathrm{Q}$ ), multiply C accuracy by $(1+\mathrm{D})$.

## D Q Accuracy:

For all $D$, accuracy of $D= \pm\left[\tan \left(\theta_{\text {Acc }}\right) \times\left(D^{2}-1\right)\right] /\left[1+D \times \tan \left(\theta_{\text {Acc }}\right)\right]$
For $\mathrm{Q} \leq 10$, accuracy of $\mathrm{Q}= \pm\left[\tan \left(\theta_{\text {Acc }}\right) \mathrm{x}\left(1+\mathrm{Q}^{2}\right)\right] /\left[1-\mathrm{Q} x \tan \left(\theta_{\text {Acc }}\right)\right]$
For $\mathrm{Q} \geq 10$, accuracy of $\mathrm{Q}=$ multiply accuracy by $(1+1 / \mathrm{Q})$
$\theta_{\text {Acc }}=\theta$ accuracy value listed in Table 2-6

## R Accuracy (ESR, EPR):

For $\mathrm{Q} \leq 0.1$, accuracy of $\mathrm{R}=$ Accuracy of $|\mathrm{Z}|$
For $\mathrm{Q} \geq 0.1$, accuracy of $\mathrm{R}=$ multiply accuracy by $(1+\mathrm{Q})$


### 2.9 Memory Data Storage

The 1750 Digibridge instrument has battery back-up capability to save the current power down conditions in addition to the 10 memory locations that store and recall specific test setups.

At Power Down the 1750 instrument automatically stores the following conditions:

1. Primary Parameter: L C R or $|\mathrm{Z}|$ ( $\Delta$ or $\Delta \%$ if comparison enabled)
2. Secondary Parameter: Q D R or $\theta$
3. Measurement Rate: Fast, Slow or Medium
4. Measurement Range: AUTO or Manual (HOLD)
5. Equivalent Circuit Representation: PAR or SER
6. Open/Short Zero Value
7. Test Frequency
8. Test Voltage
9. Trigger Mode: INT (Internal) or EXT (External)

If the Comparison Function is enabled and the keypad locked (KEY LOCK LED is lit) at power down, the 1750 instrument also stores:

1. Keypad Locked State (only [PROG] and [LOCK] function)
2. Nominal Value
3. Bin Limits (including nominal value)

When STORE is activated the 1750 instrument stores the following conditions:

1. Primary Parameter: L C R or $|\mathrm{Z}|$ (but NOT $\Delta$ or $\Delta \%$ )
2. Secondary Parameter: Q D R or $\theta$
3. Measurement Rate: Fast, Slow or Medium
4. Measurement Range: AUTO or Manual (HOLD)
5. Equivalent Circuit Representation: PAR or SER
6. Test Frequency
7. Test Voltage
8. Nominal Value
9. Bin Limits (including nominal value)

## NOTE

The Open/Short Zero Value is not saved when STORE function is activated.
The Trigger Mode is not saved when STORE function is activated.

## Section 3: Interface

### 3.1 IEEE-488 Interface

The 1750 Digibridge unit can be operated by remote control using the IEEE-488 interface for data transfer. Connection is through the rear panel via a blue $24-\mathrm{PIN}$ connector labeled IEEE-488 INTERFACE. Figure 3-1 illustrates the pin configuration of the IEEE-488 interface connector. The meter side connector is a DDK 57LE-20240 or equivalent type. The cable side connector is a DDK 57-10240 or equivalent type.


1750 IEEE-488 Interface PIN Configuration: Rear Panel View


1750 IEEE-488 Interface PIN Configuration: Circuit Diagram
Figure 3-1: 1750 IEEE-488 Interface PIN Configuration

### 3.1.1 Interface Codes

Table 3-1 lists the IEEE-488 Interface Codes and their respective functions. All front panel functions are programmable form the bus. All data is available as output to the bus. The output form is ASCII. The interface is composed of the data bus, the handshake bus and the control bus.

Table 3-1: IEEE-488 Interface Codes

| Code | Function |
| :--- | :--- |
| AH1 | Acceptor Handshake (Listener) |
| SH1 | Source Handshake (Talker) |
| T6 | Basic Talker Function |
| L4 | Basic Listener Function |
| RL1 | All Remote Local Functions |
| PP0 | No Parallel Poll Function |
| DC0 | No Device Clear Function |
| DT1 | Device Trigger Function |
| C0 | No Controller Function |

### 3.1.2 TALK/LISTEN DIP Switch

A red 4-position DIP switch labeled TALK/LISTEN, is located on the rear panel of the 1750 instrument. Figure 3-2 illustrates the TALK/LISTEN DIP Switch. Depending on the position of the DIP switch, the 1750 instrument functions as a TALK/LISTEN device or a TALK ONLY device. TALK/LISTEN mode allows full programming functions and is suitable for a system that has a controller or computer to manage data flow. TALK ONLY mode is suitable for a system that has no controller and no other talker. (Example: the 1750 instrument is connected to a printer only). Both modes provide measurement results to the listeners in the system.


Figure 3-2: TALK/LISTEN DIP Switch

### 3.1.3 Interface Bus \& Messages

Tables 3-2 describes the IEEE-488 Interface Bus and respective signal lines. Driving the bus on the 1750 instrument IEEE-488 Interface are DIO1-8, SRQ, NFRD and NDAC as open collectors and EOI, REN, DAV, IFC and ATN as 3 states.

Table 3-2: IEEE-488 Interface Bus

| PIN \# | Bus | Bus Signal Line | Description |
| :---: | :---: | :---: | :---: |
| 1 | Data Bus | DIO1 (Data Input Output 1) | Besides data input, the data bus is used for interface and device message input/output. |
| 2 |  | DIO2 (Data Input Output 2) |  |
| 3 |  | DIO3 (Data Input Output 3) |  |
| 4 |  | DIO4 (Data Input Output 4) |  |
| 13 |  | DIO5 (Data Input Output 5) |  |
| 14 |  | DIO6 (Data Input Output 6) |  |
| 15 |  | DIO7 (Data Input Output 7) |  |
| 16 |  | DIO8 (Data Input Output 8) |  |
| 6 | Handshake Bus | DAV (Data Valid) | Indicates the data on the bus is valid. |
| 7 |  | NFRD (Not Ready For Data) | Indicates the Listener is ready to receive. |
| 8 |  | NDAC ( No Data Accepted) | Indicates the Listener has finished data reception. |
| 11 | Control Bus | ATN (Attention) | Indicates the signal on the data bus carries data or an interface or a device message. |
| 17 |  | REN (Remote Enabled) | Switches between Remote and Local control modes. |
| 9 |  | IFC (Interface Clear) | Used to Reset the Interface. |
| 10 |  | SRQ (Service Request) | Signal sent to Talker side to call the Controller. |
| 5 |  | EOI (End of Identify) | Indicates end of data. |

The 1750 Digibridge instrument is capable of responding to the IEEE-488 Interface messages listed in Table 3-3.

Table 3-3: IEEE-488 Interface Message Response

| Interface Message | Response |
| :--- | :--- |
| GTL (Go To Local) | Only addressed devices that receive this <br> command are set to LOCAL. <br> Cancels the Remote Control Mode, making <br> the front panel switches operative. |

### 3.1.4 Listener Functions

All 1750 front panel functions can be operated by remote commands. The function is controlled by ASCII commands in a string composed of:

$$
\{\text { Command }+ \text { parameters }+[\text { END CODE }]\}
$$

Between instructions (command + parameter) there is no delimiter required or a delimiter with a space " " can be used. The maximum length of the string is limited to 256 characters. If the measured result has been enabled (Table 3-5, X1-X7), the 1750 instrument will output the data asked for when the specified measurement period is finished. Table 3-5 lists the Listener Commands for the 1750 Interface. The output format of the Listener Functions is divided into four categories: LCR data, DQR data, BIN Number and BIN Summary data. Tables 3-6, 3-7, 3-8 and 3-9 detail these data output formats respectively.

Table 3-5: Listener Commands

| Command | \# Bytes | Parameter Selected | Parameter Type |
| :---: | :---: | :---: | :---: |
| D0 | 2 | Bin \# | Display |
| D1 | 2 | Deviation \% |  |
| D2 | 2 | Value |  |
| D3 | 2 | Speed Rate |  |
| S0 | 2 | Fast | Measurement Speed |
| S1 | 2 | Medium |  |
| S2 | 2 | Slow |  |
| Vv; | Floating Point | $\mathrm{v}=$ value (in volts) | Test Voltage |
| T0 | 2 | External | Trigger Mode |
| T1 | 2 | Internal |  |
| M0 | 2 | Inductance (L/Q) | Measurement Parameter |
| M1 | 2 | Capacitance (C/D) |  |
| M2 | 2 | Capacitance (C/R) |  |
| M3 | 2 | Resistance (R/Q) |  |
| C0 | 2 | Parallel | Equivalent Circuit |
| C1 | 2 | Series |  |
| R0 | 2 | Hold Range | Range Control |
| R1 | 2 | Hold Range 1 |  |
| R2 | 2 | Hold Range 2 |  |
| R3 | 2 | Hold Range 3 |  |
| R4 | 2 | Hold Range 4 |  |
| R5 | 2 | Hold Range 5 |  |
| R6 | 2 | Hold Range 6 |  |
| R7 | 2 | Hold Range 7 |  |
| R8 | 2 | Auto Range |  |

Table 3-5: Listener Commands (Continued)

| Command | \# Bytes | Parameter Selected | Parameter Type |
| :---: | :---: | :---: | :---: |
| Ff; | Floating Point | $\mathrm{f}=$ value (in kHz) | Test Frequency |
| X0 | 2 | Prohibit | Output Data |
| X1 | 2 | Bin \# |  |
| X2 | 2 | DQR |  |
| X3 | 2 | DQR, Bin \# |  |
| X4 | 2 | LCR |  |
| X5 | 2 | LCR, Bin \# |  |
| X6 | 2 | LCR, DQR |  |
| X7 | 2 | LCR, DQR, Bin \# |  |
| Nn; | Floating Point | $\mathrm{n}=$ value (in $\Omega$, H or F ) | Nominal Value |
| Bbb | 3 | Bin \# | Entry Limit |
| Hh; | Floating Point | $\mathrm{h}=$ High Limit (\%) |  |
| Ll; | Floating Point | l = Low Limit (\%) |  |
| G0 | 2 | Start a measurement | Trigger |
| W0 | 2 | Enable | Manual Start |
| W1 | 2 | Prohibit |  |
| E0 | 2 | Prohibit Output | Bin Summary |
| E1 | 2 | Enable Output |  |
| E2 | 2 | Zero |  |

Table 3-6: LCR Data Output Format

| Character Sequence | Purpose | Allowed Characters | Description |
| :---: | :---: | :---: | :---: |
| 1 | Status | (space) | Normal operation, measurement on a basic range |
|  |  | U | Under range Held |
|  |  | O | Over range Held |
|  |  | E | End extension of range 1 or 4 |
|  |  | I | Invalid measurement due to signal overload |
| 2 | Value, Delta LCR or Ratio | (space) | Normal Display |
|  |  | $\wedge$ | $\Delta$ LCR Mode |
| 3 | Measurement Parameter | L | Inductance |
|  |  | C | Capacitance |
|  |  | R | Resistance |
|  |  | Z | Impedance |
| 4 | Format | (space) |  |
| 5,6 | A-Units | (space) H | Henries |
|  |  | MH | MilliHenries |
|  |  | MF | Millifarads |
|  |  | $\mu \mathrm{F}$ | Microfarads |
|  |  | nF | Nanofarads |
|  |  | (space) \% | Deviation percentage |
|  |  | (space) O | Ohms |
|  |  | KO | Kilohms |
| 7 | Format | (space) |  |
| 8 | Sign | (space) | Positive L, C, R, $\Delta \%$ or $\Delta \mathrm{LCR}$ |
|  |  | - | Negative L, C, R, $\Delta \%$ or $\Delta$ LCR |
| 9 | Number | $\begin{aligned} & 012345 \\ & 6789 . \\ & \text { (space) } \end{aligned}$ | Measurement Value |
| 10 |  |  |  |
| 11 |  |  |  |
| 12 |  |  |  |
| 13 |  |  |  |
| 14 |  |  |  |
| 15 |  |  |  |
| 16 |  | (CR) | Carriage Return |
| 17 | Delimiter | (LF) | Line Feed Character; end of string |

Table 3-7: DQR Data Output Format

| Character Sequence | Purpose | Allowed Characters | Description |
| :---: | :---: | :---: | :---: |
| 1 | Status | (space) | Operation okay |
|  |  | O | Over the range of the display |
|  |  | I | Measurement wrong |
| 2 | Format | (space) |  |
| 3 | Measurement Parameter | Q | Quality Factor |
|  |  | D | Dissipation Factor |
|  |  | R | Resistance |
|  |  | S | Phase Angle ( $\theta$ ) |
| 4 | Format | (space) |  |
| 5 | A-Units | (2 space) O | Ohms <br> Kilohms <br> Dimensionless (Q, D) |
| 6 |  | (space) KO |  |
| 7 |  | (3 space) O |  |
| 8 | Format | (space) |  |
| 9 | Polarity | (space) | Positive D, Q, R, S |
|  |  | - | Negative D, Q, R, S |
| 10 | Number | $\begin{aligned} & 012345 \\ & 6789 . \\ & \text { (space) } \end{aligned}$ | Measurement Value |
| 11 |  |  |  |
| 12 |  |  |  |
| 13 |  |  |  |
| 14 |  |  |  |
| 15 |  |  |  |
| 16 |  | (CR) | Carriage Return |
| 17 | Delimiter | (LF) | Line Feed Character; end of string |

Table 3-8: BIN Number Data Output Format

| Character Sequence | Purpose | Allowed Characters | Description |
| :---: | :---: | :---: | :---: |
| 1 | Status | (space) | GO (BIN 1-BIN 13) |
|  |  | F | NG (BIN 0 or BIN 14) |
| 2 | Format | (space) |  |
| 3 | Note | B | The word "BIN" |
| 4 |  | I |  |
| 5 |  | N |  |
| 6 | Format | (space) |  |
| 7 | Bin Number | 012345 | BIN Number Assignment, 00-14 |
| 8 |  | 6789 |  |
| 9 |  | (CR) | Carriage Return |
| 10 | Delimiter | (LF) | Line Feed Character; end of string |

NOTE
When the LCR measurement is NG, the A Display will show "F" and the IEEE-488 Interface will output 14.
Table 3-9: BIN Summary Data Output Format

| Character Sequence | Purpose | Allowed Characters | Description |
| :---: | :---: | :---: | :---: |
| 1 | Status | (space) | GO (BIN 1 - BIN 8) |
|  |  | F | NG (BIN 0 or BIN 9) |
| 2 | Format | (space) |  |
| 3 | Note | B | The word "BIN SUM" |
| 4 |  | I |  |
| 5 |  | N |  |
| 6 |  | S |  |
| 7 |  | U |  |
| 8 |  | M |  |
| 9 | Format | (space) |  |
| 10 | BIN Number | $\begin{aligned} & 012345 \\ & 6789 \\ & \hline \end{aligned}$ | Bin Summary Number, 00-14 |
| 11 |  |  |  |
| 12 | Equivalence | $=$ | Equal |
| 13 | Sum | $\begin{aligned} & 012345 \\ & 6789 \end{aligned}$ | Total Number counted in this bin, the bin-summary number |
| 14 |  |  |  |
| 15 |  |  |  |
| 16 |  |  |  |
| 17 |  |  |  |
| 18 |  | (CR) | Carriage Return |
| 19 | Delimiter | (LF) | Line Feed Character; end of string |

### 3.2 Handler Interface

On the rear panel of the 1750 Digibridge instrument is a blue 24 -PIN connector labeled HANDLER INTERFACE for remote operation with a handler device. Connect the control lines to the handler. Figure 3-3 illustrates the pin configuration of the Handler Interface connector.


1750 Handler Interface PIN Configuration: Rear Panel View


1750 Handler Interface PIN Configuration: Circuit Diagram
Figure 3-3: 1750 Handler Interface PIN Configuration

The output signal comes from open collector drivers that pull each signal line to a low voltage when the signal is active and let it float when it is inactive. Each external circuit must be powered by a positive voltage up to 30 V (max), with sufficient impedance (pullup resistors) to limit the active signal (logic-low) current to 16 mA (max).

## CAUTION

Each relay or other inductive load requires a CLAMPING DIODE (rectifier) across it.
Typically, a cathode connected to the power supply end of the load.
Table 3-11 lists the name, pin \# and function of each control signal for the 1750 instrument Handler Interface. All signals are 'active low".

Table 3-11: Handler Interface

| Signal Name | PIN \# | Function |
| :--- | :--- | :--- |
|  | $5,6,7$ | Ground Connection |
|  | 10 | DC bus (+5V) available; commonly for optocouplers <br> Limit the load to 25mA (MAX) |
| START | 1 | Initiates Measurement (External Trigger) |
| EOM | 18 | "End of Measurement", Judgment signals are valid |
| ACQ over | 22 | "Data Acquisition over", DUT removal okay |
| BIN 0 | 15 | No Good because of Q, D, R or $\theta$ limit |
| BIN 1 | 17 | GO, bin 1 |
| BIN 2 | 19 | GO, bin 2 |
| BIN 3 | 21 | GO, bin 3 |
| BIN 4 | 23 | GO, bin 4 |
| BIN 5 | 14 | GO, bin 5 |
| BIN 6 | 16 | GO, bin 6 |
| BIN 7 | 20 | GO, bin 7 |
| BIN 8 | 24 | GO, bin 8 |
| BIN 9 | 9 | L, C, R, 1 Z <br> No Gair, |

The input signal is also active low and requires a positive-voltage external circuit which must pull the signal line down below 0.4 V but not less than 0 V (i.e. not negative). The logic low current is 0.4 mA (maximum). For the inactive state (logic high) the external circuit must pull the signal line above +2.5 V but not above +5 V .

### 3.2.1 Handler Interface Timing

## NOTE

To enable the Handler outputs, the 1750 instrument requires that a non-zero value be entered for "nominal value" and the primary parameter be matched.

Figure 3-4 illustrates the timing diagram of the 1750 Handler Interface. The START signals are expanded for clarity. The START signal must have a duration of $1 \mu \mathrm{~s}$ (minimum) in each state (high and low). If START is provided by a mechanical switch without de-bounce circuitry, the instrument may make false STARTs.


Figure 3-4: Handler Interface Timing Diagram
Measurement starts at time "c" which is essentially the same as time "a". Measurement is completed at time ' f ". Interval "a-b"(during which the DUT must remain connected for data acquisition) is considerably shorter than "a-f" the total measurement time. The DUT can be changed after " d " ("indexing on ACQ", to save time) or after " f " ("indexing on EOM", for a simpler measurement set up). After the calculation interval "d-e", measurement results are available for judgment and active lines go low. A few $\mu$ sec later, EOM goes low and can be used to latch hold the result assignment. ACQ OVER, the active result lines and EOM stay low until the next START command.

### 3.2.2 Handler Setup

The Handler may be set up in either of two ways: "Index on EOM" or "Index on ACQ". The Handler must supply a signal to initiate measurement when it has completed connection of the DUT to the test fixture. The simpler set up is to "Index on EOM".

### 3.2.2.1 Index on EOM

Set up the Handler to respond to the EOM signal from the 1750 instrument. The EOM signal occurs at the "end of measurement" when the judgment result is available. Set up the 1750 instrument to receive its START signal from the Handler's "Start measurement" signal. (They talk to each other via their respective START signals).

### 3.2.2.2 Index on ACQ

Set up the Handler to respond to the ACQ OVER signal from the 1750 instrument. The ACQ OVER signal occurs when the "data acquisition" is complete. The Handler can then remove the DUT from the test fixture and replace it with another DUT while the 1750 instrument is calculating the result. This set up results in a faster measurement rate than "Indexing on EOM".

## Section 4: Service \& Calibration

### 4.1 General

Our warranty (at the front of the manual) attests the quality of materials and workmanship in our products. If malfunction should be suspected, or other information be desired applications engineers are available for technical assistance. Application assistance is available in the U.S. by calling 978-461-2100 and asking for Applications Support. For support outside of the United States please contact your local QuadTech distributor.

### 4.2 Instrument Return

Before returning an instrument to QuadTech for service please call our Customer Care Center (CCC) at 800-253-1230 for Return Material Authorization (RMA). It will be necessary to include a Purchase Order Number to insure expedient processing, although units found to be in warranty will be repaired at no-charge. For any questions on repair costs or shipment instructions please contact our CCC Department at the above number. To safeguard an instrument during storage and shipping please use packaging that is adequate to protect it from damage, i.e., equivalent to the original packaging and mark the box "Delicate Electronic Instrument". Return material should be sent freight prepaid, to:

QuadTech, Inc.
5 Clock Tower Place, 210 East
Maynard, MA 01754
Attention: RMA \#
Shipments sent collect can not be accepted.

### 4.3 Calibration

The 1750 Digibridge instrument is calibrated via an open and short compensation, a routine procedure when using this instrument. Refer to paragraph 2.3.7. There are no necessary calibration adjustments on the 1750 instrument. Performance verification can be performed using selected resistance, capacitance and inductance standards as desired.

